



Cornell University
Laboratory for Elementary-Particle Physics



Temperature Map Studies on Nearly Oxide-Free, Thin-Oxide and Standard-Oxide Cavities

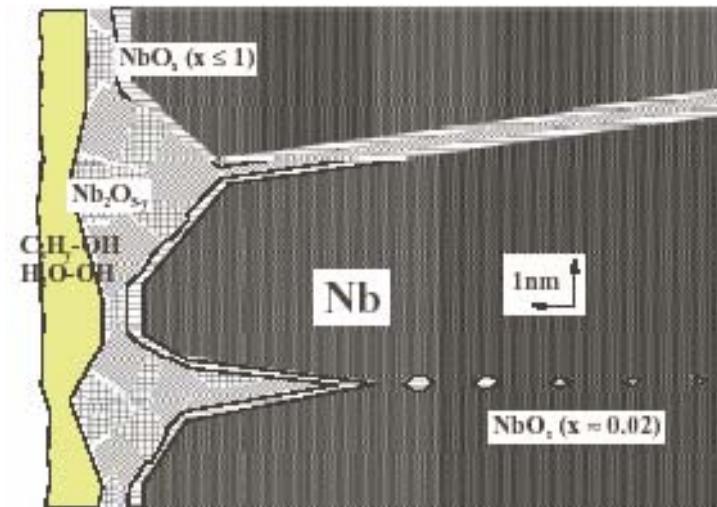
Grigory Eremeev

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Cornell Laboratory for Elementary-Particle
Physics





Motivation



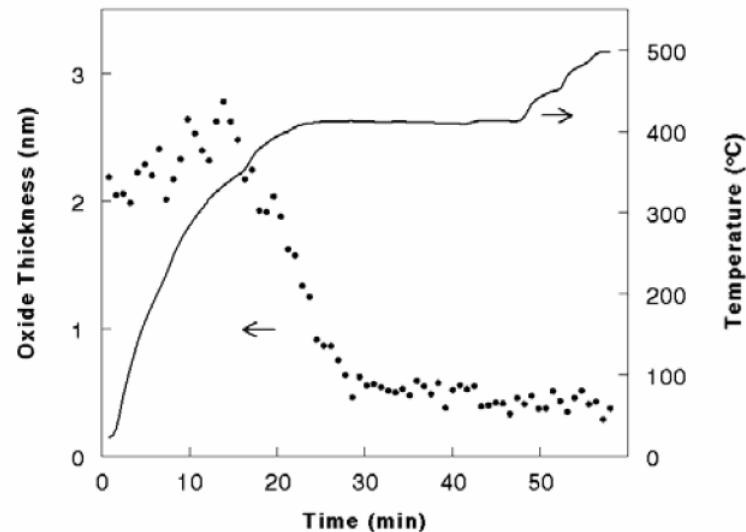


Figure 7. Sample #2, total oxygen core level peak vs. T.
Peak intensities are measured above background

R. Kirby et al., SLAC-TN-05-049, 2005

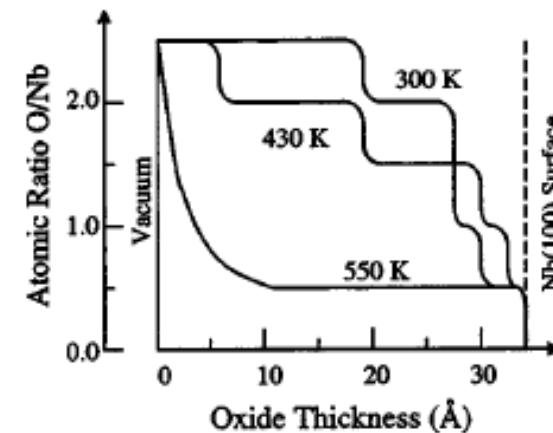


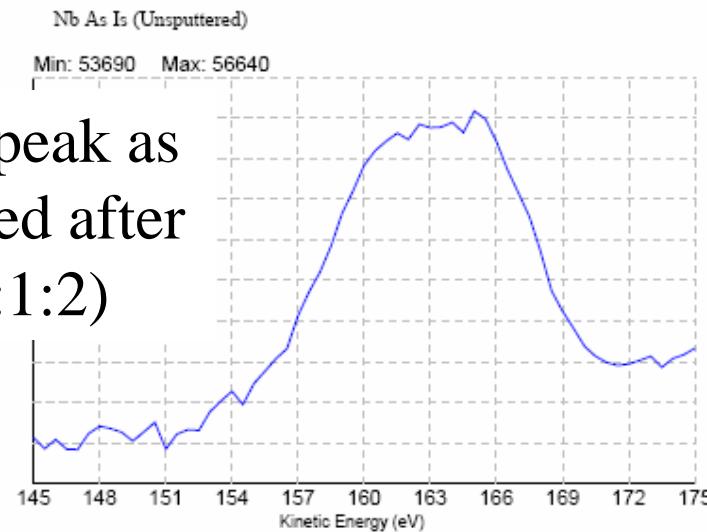
FIG. 5. Schematic for evolution of the oxide composition upon annealing at 430 and 550 K, respectively. The figure is presented from the vacuum/oxide interface to the Nb(100) surface as indicated.

Q. Ma et al., JAP, 96, 12, 2004

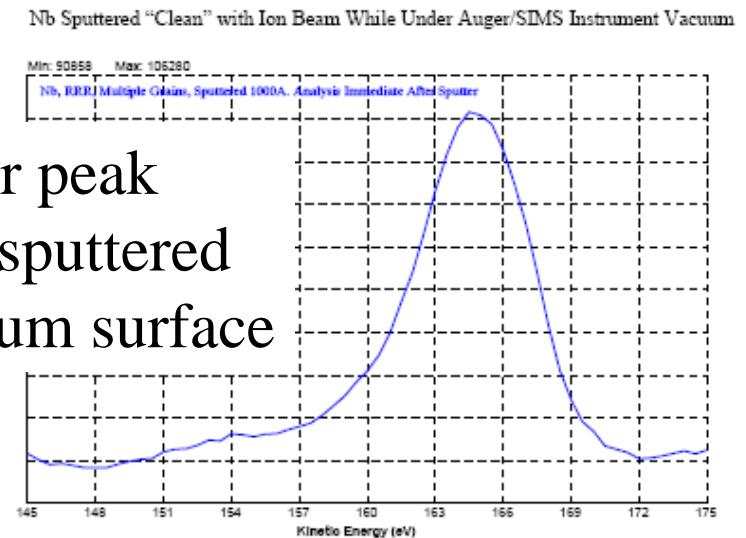


Surface composition

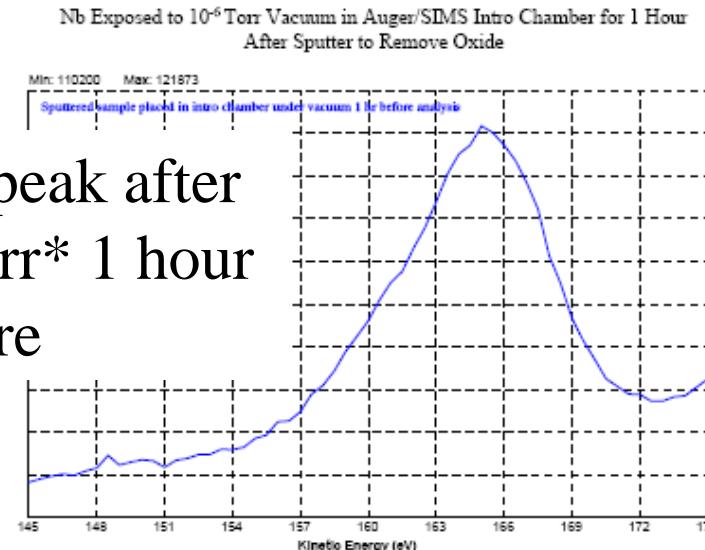
Auger peak as
Received after
BCP(1:1:2)



Auger peak
for a sputtered
niobium surface



Auger peak after
10⁻⁶ Torr* 1 hour
exposure

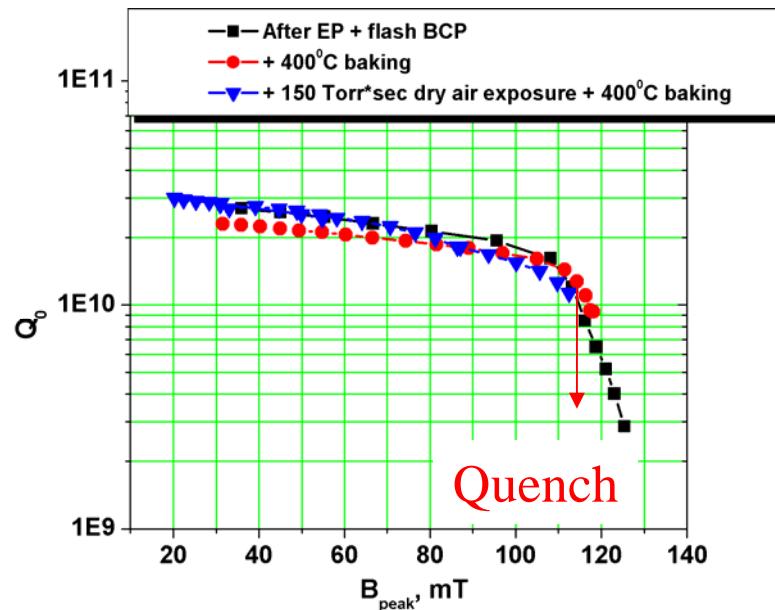


J. Kaufman et al., SRF, 2005

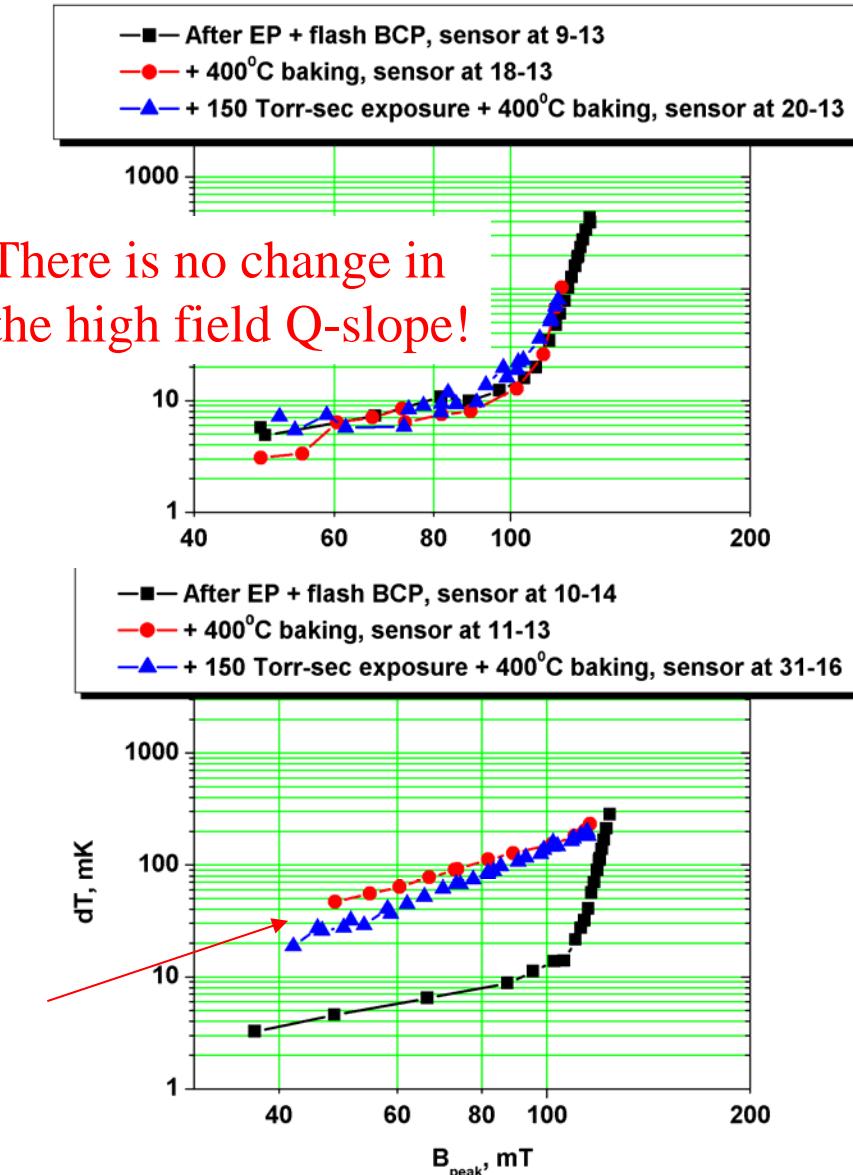


Effect of 400°C baking

LE1-36, ~ 1-3 mm grain size,
VEP + flash BCP



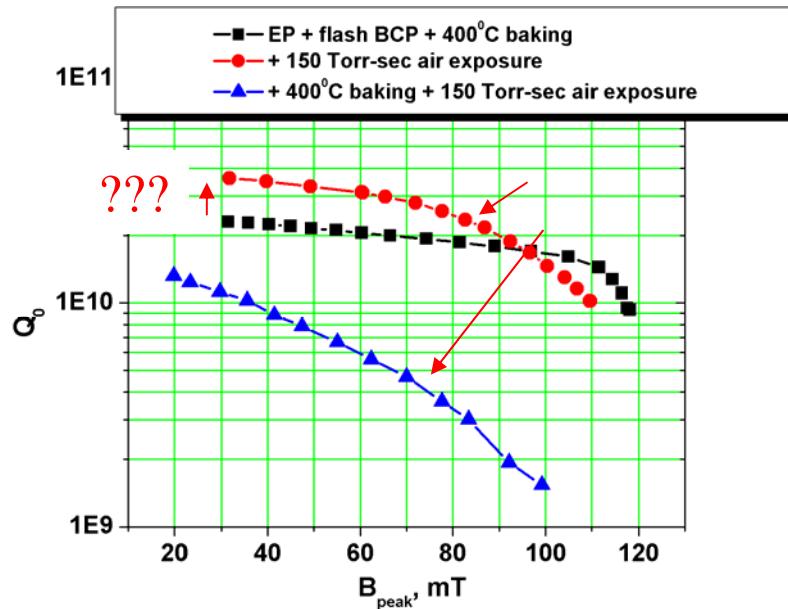
A few high resistance regions are formed by 400°C baking





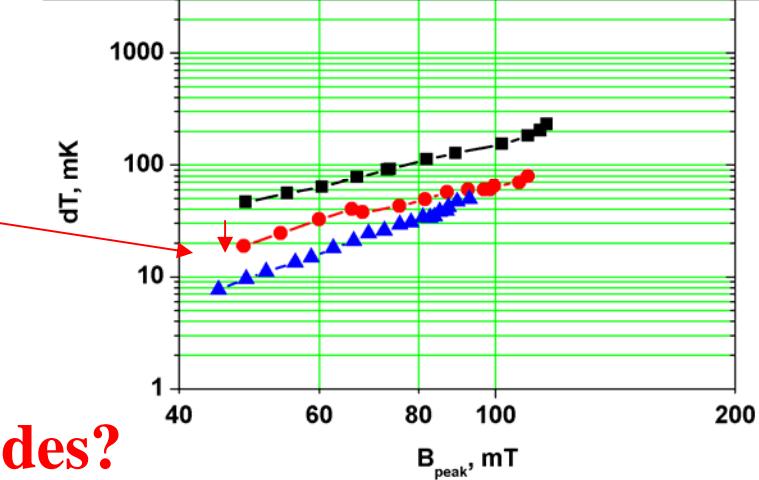
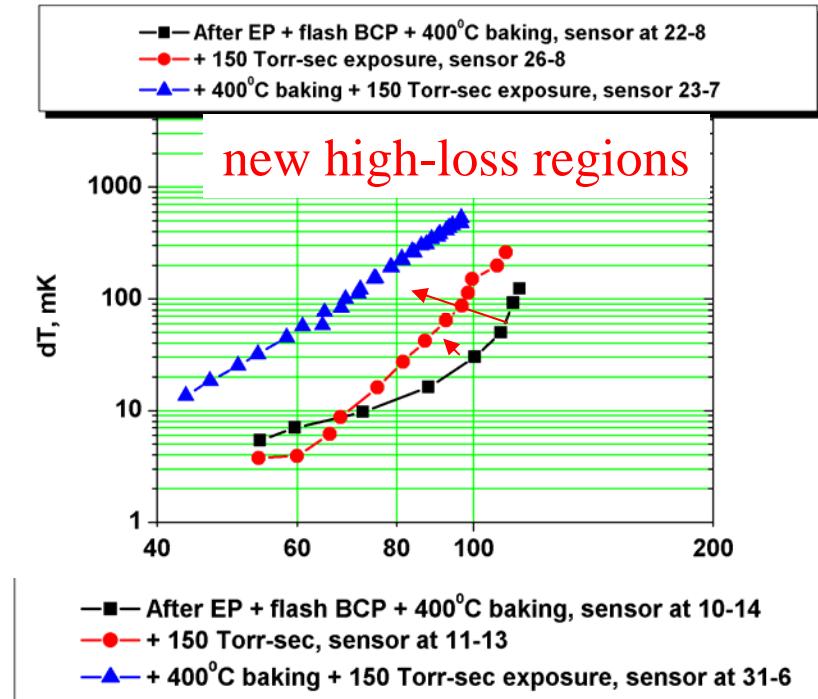
Effect of short exposure

Short exposure causes
a strong medium field Q-slope



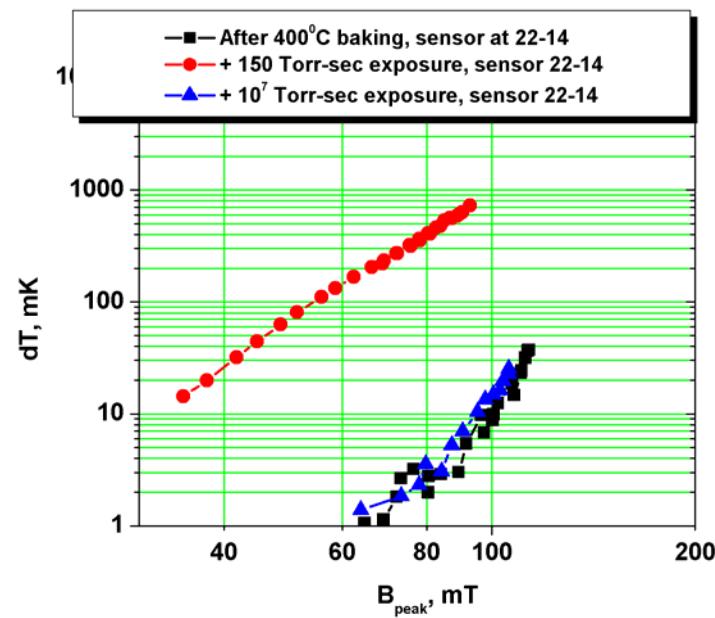
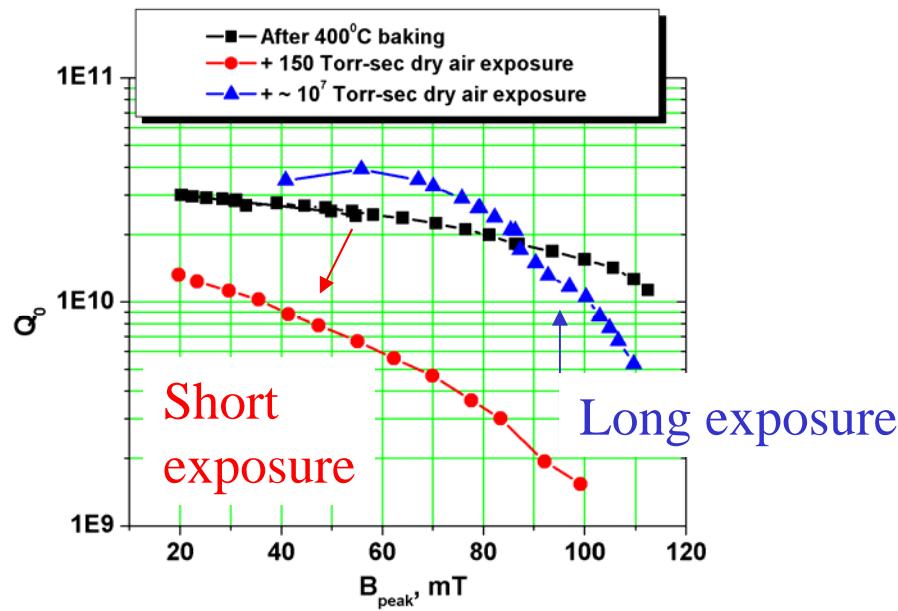
High quadratic loss regions,
which appeared after 400°C
baking, are improved by short
exposure

Formation of high loss sub-oxides?





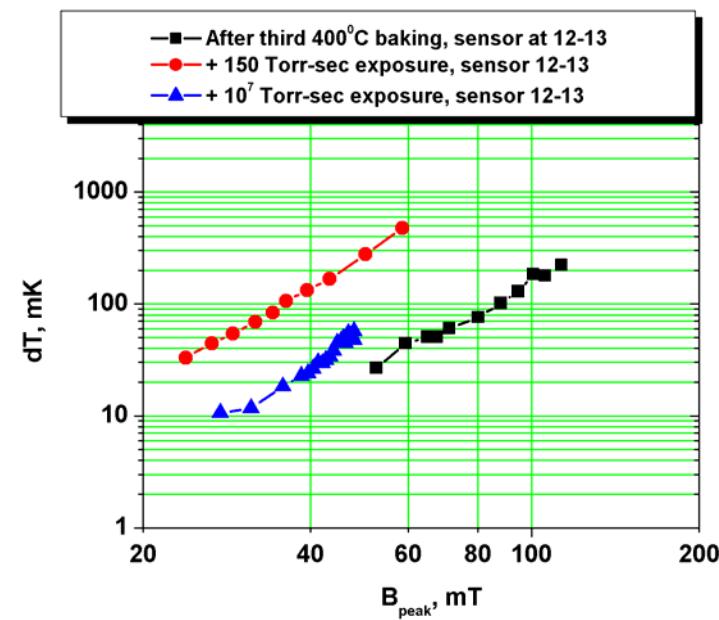
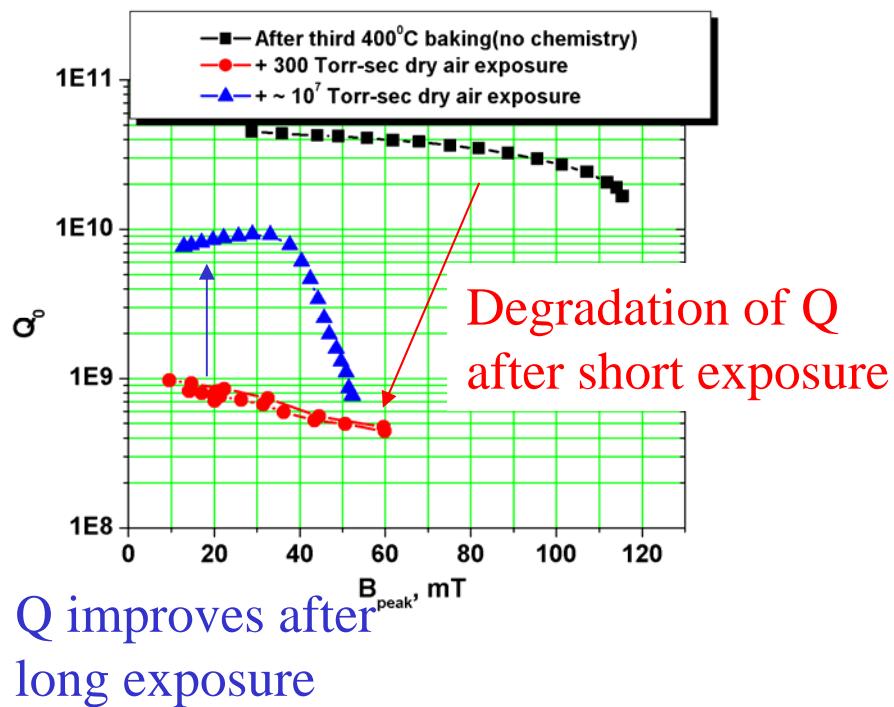
Long exposure after a short one causes improvement in quality factor



Conversion of sub-oxides to pentoxide?



Third set of experiments, no chemistry





Conclusion

Niobium surface after chemistry

